

ELECTRONIC INFORMATION DISCLOSURE STATEMENT

Electronic Version v18

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Title of Invention	DEFECT DIAGNOSIS FOR SEMICONDUCTOR INTEGRATED CIRCUITS
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Application Number : 10/710,879

Confirmation Number:

First Named Applicant: James Adkisson

Attorney Docket Number: BUR920040092US1

Art Unit: 2825

Examiner: TUYEN TO

Search string: (6636064 or 6605956 or 6566885 or 6524873 or 6347386 or 6308290 or 6185707 or 5923533 or 4947357).pn

US Patent Documents

Note: Applicant is not required to submit a paper copy of cited US Patent Documents

init	Cite.No.	Patent No.	Date	Patentee	Kind	Class	Subclass
TT	1	6636064	2003-10-21	Satya et al.			
TT	2	6605956	2003-08-12	Farnworth et al.			
TT	3	6566885	2003-05-20	Pinto et al.			
TT	4	6524873	2003-02-25	Satya et al.			
TT	5	6347386	2002-02-12	Beffa			
TT	6	6308290	2001-10-23	Forlenza et al.			
TT	7	6185707	2001-02-06	Smith et al.			
TT	8	5923533	1999-07-13	Yi			
TT	9	4947357	1990-08-07	Stewart et al.			

Signature



Examiner Name	Date
TUYEN TO	01-30-2006



INFORMATION DISCLOSURE CITATION
(Use several sheets if necessary)

Docket Number (Optional)	BUR920040092US1	Application Number	10/710879
Applicant(s)	Adkisson et al.		
Filing Date	08/10/2004	Group Art Unit	2825

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

U.S. PATENT APPLICATION PUBLICATIONS

EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
							YES	NO
TT		014661	12/1986	EPO				

OTHER DOCUMENTS *(Including Author, Title, Date, Pertinent Pages, Etc.)*

TT		K. W. Lallier et al., RELATING LOGIC DESIGN TO PHYSICAL GEOMETRY IN LSI CHIP, Vol. 19, No. 6, November 1976, pages 2140-2143.

EXAMINER <i>Truman Jr.</i>	DATE CONSIDERED <i>01-30-2006</i>
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	